

DTL7N70SJ-VB Datasheet

N-Channel 700V (D-S) Super Junction Power MOSFET

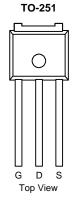
PRODUCT SUMMARY				
V _{DS} (V) at T _J max.	700			
R _{DS(on)} max. at 25 °C (Ω)	V _{GS} = 10 V	0.75		
Q _g max. (nC)	23			
Q _{gs} (nC)	2.3			
Q _{gd} (nC)	15			
Configuration	Single			

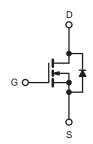
FEATURES

- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (Ciss)
- · Reduced switching and conduction losses
- Ultra low gate charge (Qq)
- Avalanche energy rated (UIS)

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial





N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ($T_{\rm C}$	= 25 °C, unl	less otherwis	se noted)			
PARAMETER		SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V_{DS}	700	V		
Gate-Source Voltage			V_{GS}			± 30
Continuous Drain Current (T, = 150 °C)	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	L	7		
Continuous Drain Current (1) = 130 °C)	VGS at 10 V	T _C = 100 °C	I _D	5.9	А	
Pulsed Drain Current ^a		I _{DM}	12			
Linear Derating Factor				1.89/1.55/0.5	W/°C	
Single Pulse Avalanche Energy b		E _{AS}	87	mJ		
Maximum Power Dissipation			P_{D}	99/97/46	W	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +150	°C		
Drain-Source Voltage Slope T _J = 125 °C		dV/dt	50	V/ns		
Reverse Diode dV/dt ^d		uv/at	3.2	V/11S		
Soldering Recommendations (Peak Temperature) c for 10 s		10 s		300	°C	

- a. Repetitive rating; pulse width limited by maximum junction temperature. b. $V_{DD}=50$ V, starting $T_J=25$ °C, L=28.2 mH, $R_g=25$ Ω , $I_{AS}=3.5$ A.
- c. 1.6 mm from case.
- d. $I_{SD} \le I_D$, $dI/dt = 100 \text{ A/}\mu\text{s}$, starting $T_J = 25 \,^{\circ}\text{C}$.



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	72	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.7	C/ VV

PARAMETER	SYMBOL	TES	T CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static						•	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D = 250 μA	700	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.65	-	V/°C
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2	-	4	V
			V _{GS} = ± 20 V	-	-	± 100	nA
Gate-Source Leakage	I_{GSS}		V _{GS} = ± 30 V	-	-	± 1	μΑ
		V _{DS} =	= 700 V, V _{GS} = 0 V	-	-	1	
Zero Gate Voltage Drain Current	I_{DSS}		/, V _{GS} = 0 V, T _J = 125 °C	-	-	10	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 4 A	-	0.75	-	Ω
Forward Transconductance	9 _{fs}	V _{DS}	= 30 V, I _D = 4 A	-	17	-	S
Dynamic					,	•	
Input Capacitance	C _{iss}		$V_{GS} = 0 V$,	-	366	-	
Output Capacitance	C _{oss}	1	$V_{DS} = 100 \text{ V},$	-	27	-	
Reverse Transfer Capacitance	C _{rss}	1	f = 1 MHz	-	13	-	1
Effective Output Capacitance, Energy Related ^a	C _{o(er)}	V 01	/+- F00 V V	-	46	-	pF
Effective Output Capacitance, Time Related ^b	C _{o(tr)}	$V_{DS} = 0.0$	/ to 520 V, V _{GS} = 0 V	-	64	-	
Total Gate Charge	Qg			-	26		
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 4 A, V_{DS} = 520 V$	-	2.1	-	nC
Gate-Drain Charge	Q _{gd}			-	2.8	-	
Turn-On Delay Time	t _{d(on)}			-	26	-	
Rise Time	t _r	Vpp	$V_{DD} = 520 \text{ V}, I_D = 4 \text{ A},$		55.7	-	ns
Turn-Off Delay Time	t _{d(off)}		= 10 V, $R_g = 9.1 \Omega$	-	71	-	113
Fall Time	t _f	V _{GS} = 10 V, n _g = 9.1 Ω		-	41	-	
Gate Input Resistance	R_{g}	f = 1	MHz, open drain	-	3.5	-	Ω
Drain-Source Body Diode Characteristic	S						
Continuous Source-Drain Diode Current	I _S	MOSFET sym	MOSFET symbol showing the		-	7	
Pulsed Diode Forward Current	I _{SM}	integral revers	₹ □ 7	-	-	18	A
Diode Forward Voltage	V _{SD}	T _J = 25 °	C, I _S = 4 A, V _{GS} = 0 V	-	-	1.4	V
Reverse Recovery Time	t _{rr}			-	192	-	ns
Reverse Recovery Charge	Q _{rr}	$T_J = 2$	25 °C, $I_F = I_S = 4$ A,	-	2.4	_	μC
Reverse Recovery Current	I _{RRM}	dl/dt = 100 A/ μ s, V_R = 400 V			11	-	A

Notes

- a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

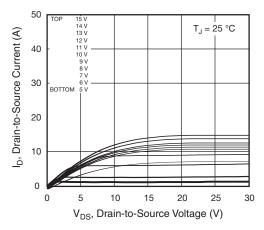


Fig. 1 - Typical Output Characteristics

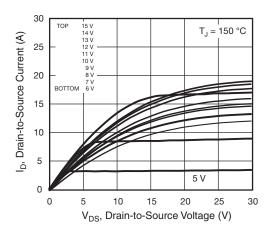


Fig. 2 - Typical Output Characteristics

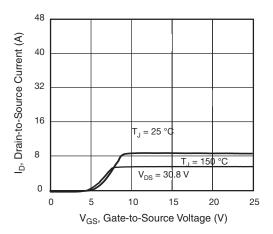


Fig. 3 - Typical Transfer Characteristics

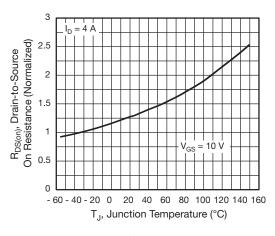


Fig. 4 - Normalized On-Resistance vs. Temperature

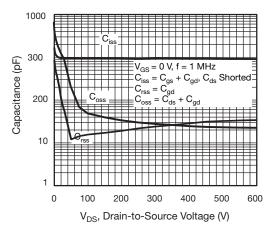


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

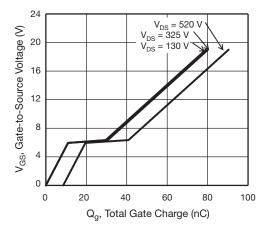


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



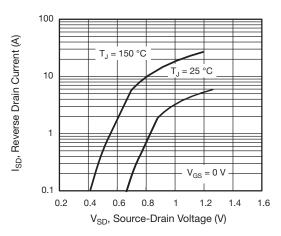
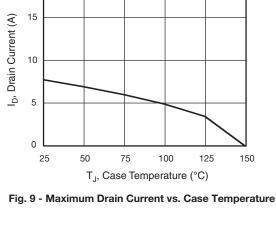


Fig. 7 - Typical Source-Drain Diode Forward Voltage



20

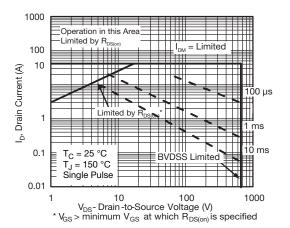


Fig. 8 - Maximum Safe Operating Area

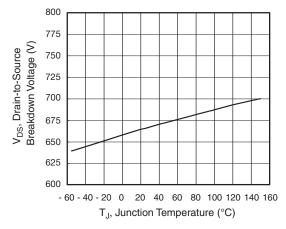


Fig. 10 - Temperature vs. Drain-to-Source Voltage

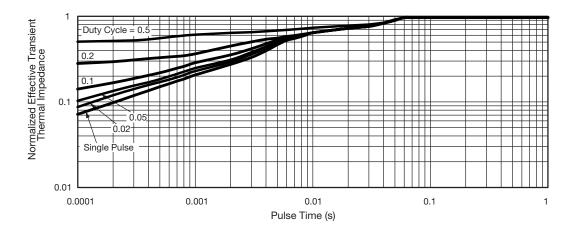


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



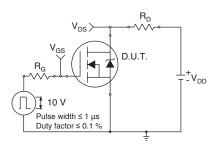


Fig. 12 - Switching Time Test Circuit

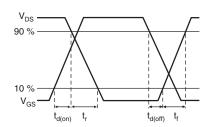


Fig. 13 - Switching Time Waveforms

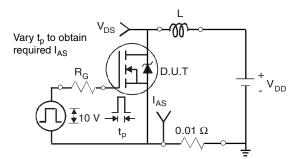


Fig. 14 - Unclamped Inductive Test Circuit

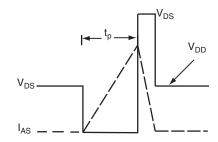


Fig. 15 - Unclamped Inductive Waveforms

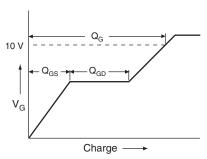


Fig. 16 - Basic Gate Charge Waveform

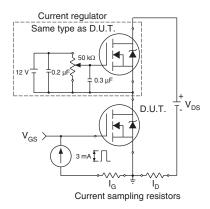
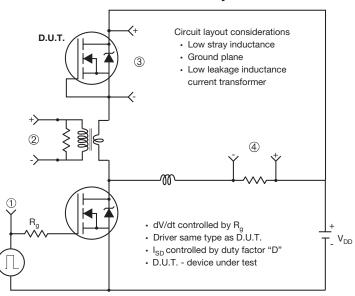


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



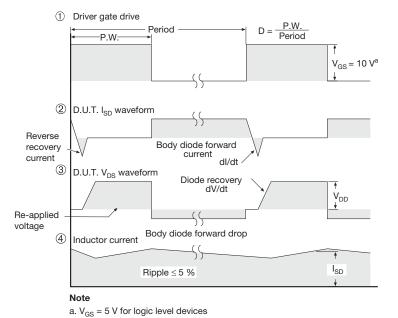
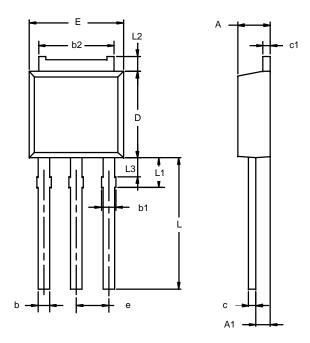


Fig. 18 - For N-Channel



TO-251AA (DPAK)



Note: Dimension L3 is for reference only.

	MILLIN	METERS	INCHES		
Dim	Min	Max	Min	Max	
Α	2.21	2.38	0.087	0.094	
A 1	0.89	1.14	0.035	0.045	
b	0.71	0.89	0.028	0.035	
b1	0.76	1.14	0.030	0.045	
b2	5.23	5.43	0.206	0.214	
С	0.46	0.58	0.018	0.023	
с1	0.46	0.58	0.018	0.023	
D	5.97	6.22	0.235	0.245	
Е	6.48	6.73	0.255	0.265	
е	2.28 BSC		0.090 BSC		
L	3.89	9.53	0.153	0.375	
L1	1.91	2.28	0.075	0.090	
L2	0.89	1.27	0.035	0.050	
L3	1.15	1.52	0.045	0.060	



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